

Application/Control No.	Applicant(s)/Patent under Reexamination
10/718,151	LIN, I-JONG
Examiner	Art Unit
Alex Liew	2624

	SEARCHED				
Class	Subclass	Date	Examiner		

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
348/586-589,592 limited to text search	3/25/2007	AL
382/173 limited to text search	3/25/2007	AL
382/154 limited to text search	8/31/2007	AL .
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